


<b>Search Notes</b>  	<b>Application/Control No.</b>  10527911	<b>Applicant(s)/Patent Under Reexamination</b>  KNEE ET AL.
	<b>Examiner</b>  EUENG-NAN YEH	<b>Art Unit</b>  2624

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SEARCH NOTES		
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(382/172) text search - see search outputs	2008/02/06	/ey/
(382/173,164,171) text search - see search outputs	2008/03/14	/ey/
EAST text search - see search outputs	2008/02/06	/ey/
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